

<b>Notice of References Cited</b>	Application/Control No. 10/790,394		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Alvin C. Chin-Shue		Art Unit 3634	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,604,315	08-1986	McCall et al.	442/182
*	B	US-4,746,769	05-1988	Piper, Douglas E.	174/117M
*	C	US-4,897,902	02-1990	Kavesh et al.	28/166
*	D	US-2003/0173150 A1	09-2003	Sharp, C. Marty	182/3
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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